					MH 2 x 30	71				
Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.	PARTY 20	705 25/	SERIAL	SERIAL NO.		
(MODINEO) FATENT AND TROUBMARK OFFICE				132	_48 <u>\$</u> _	10/647	10/647,259			
1167.05	٥٥٤٤	DENICES CITED BY A		APPLICANT RADEMARK.						
LISTOF	KEFEF	RENCES CITED BY A	PPLICANI	Yasunori SUZUKI FILING DATE	, et al.	•	Y	<del></del> -		
							GROUP			
				August 26, 2003		<del></del>	2681			
		Ţ		U.S. PATENT DOCUM	ENTS 	T	1			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS				FILING DATE APPROPRIATE		
	AA								•	
	AB		<del> </del>			<u> </u>	<u> </u>			
	AC	·		-		ļ	-		<del></del>	
	AD	<u></u>					-			
	AE		<u> </u>			-	-	<u> </u>		
	AF	 	<del> </del>		<del></del>	<del> </del>				
	AG AH	<u> </u>		<del> </del>	·	ļ	<del> </del>			
	Al					<del> </del> -	1			
	AJ				<del></del>					
	AK									
<del></del>	AL			<del> </del>		-	<del> </del>		<del>-</del>	
	AM				<del></del>		<del></del>			
	AN					_	<del></del>			
•		J		REIGN PATENT DOCU	IMENTS	<u> </u>	<del></del> _	1	<u> </u>	
	Ι			T. T			1			
<b>\.</b>		DOCUMENT NUMBER	DATE	COUNTRY			YES		NO NO	
/EB/	AO	1337088A	02/20/2002	CHINA (submitting co			<u> </u>			
/EB/	AP	WO 00/39920	07/06/2000	WIPO (with Unedited English Translation)	Unedited Computer-Generated					
	AQ									
	AR									
	AS									
	AT								· <u>-</u>	
	AU									
	AV	<u> </u>								
		OTHER F	REFERENCES	(Including Author, Title	, Date, Pertinen	t Pages, e	etc.)	•		
	AW					-				
						<del>.</del>		· <del></del>		
	AX									
	AY									
	AZ					☐ Add	litional Refe	erences sh	eet(s) attached	
Examiner	miner /Emmanuel Bayard/ (04/03/2007)						Date Considered			
*Examiner: Ir conformance	nitial if r	reference is considered to considered.	d, whether or no	ot citation is in conformar in with next communicati	nce with MPEP 6	09; Draw	ine through	citation if	not in	
			, ,						***************************************	

Form PTO 1449  U.S. DEPARTMENT OF COMMERCE (Modified)  PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.			SERIAL NO.				
				241973US90			NEW APPLICATION			
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT						
				Yasunori SUZUKI, et	<b>a</b> l					
				FILING DATE			GROUP			
			<del></del>	HEREWITH						
	<del></del>		·	U.S. PATENT DOCUMENTS		<del></del>				
EXAMINER INITIAL		MBER	DATE	NAME	NAME CLASS				ILING DATE APPROPRIATE	
	AA									
1	AB				_					
1	AC									
/	AD									
/	AE								<u></u>	
. ,	AF				~					
1	AG		<del></del>							
,	AH									
	Al				· · · · · · · · ·					
	AJ									
<del></del>	AK		<del> </del>							
<u> </u>	AL		<del>  </del>							
	AM		<del> </del>							
ļ	AN									
			<del></del>		<del> </del>				·	
			FO	REIGN PATENT DOCUMEN	ITS 		<b></b>			
		UMENT MBER	DATE	COUNTRY			TRANSLATION YES NO			
/EB/ A	AO 10-20977	7	8/7/98	Japan (with English Abstrac	<b>オ</b> )				x	
1	AP									
F	AQ	· -								
F	AR								<del> </del>	
1	AS				·					
1	AT						<u> </u>			
1	AU						<del></del>			
,	AV					·	<del></del> :			
	<del>- 1</del>	OTHER RE	FERENCES (	Including Author, Title, Dat	e, Pertinent	Pages, e	tc.)			
4	AVV	·					·			
			<del>- · · · · · · · · · · · · · · · · · · ·</del>							
A	AX									
Α	AY									
	AZ	Additional References sheet(s) attached								
Examiner /Emmanuel Bayard/ (04/03/2007)					Date Considered					
Examiner	/Emma	anuel Bayard	d/ (04/03/2007	)		Date Con	sidered			

ATTY DOCKET NO SERIAL NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **Form PTO 1449** (Modified) 241973US90 10/647,259 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Yasunori SUZUKI, et al. FILING DATE **GROUP** August 26, 2003 2681 **U.S. PATENT DOCUMENTS EXAMINER DOCUMENT** SUB FILING DATE **CLASS** DATE NAME INITIAL NUMBER **CLASS** IF APPROPRIATE AA AB AC AD AE AF AG AH Αl AJ AK AL AM AN FOREIGN PATENT DOCUMENTS DOCUMENT TRANSLATION DATE COUNTRY NUMBER YES NO /EB/ 1337088 A CHINA (corr. WO 00/39920 was filed on 01/24/05) AO 02/20/2002 X AP AQ. AR AS AT AU AVOTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) **AW** AX AY ΑZ Additional References sheet(s) attached /Emmanuel Bayard/ (04/03/2007) Examiner **Date Considered** \*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449  U.S. DEPARTMENT OF COMMERCE (Modified)  PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 241973US90	SERIAL NO.							
PF			<del></del>	10/647,259						
LIST OF	REFER	RENCES CITED BY	ALICANT	APPLICANT Yasunori SUZUKI, et al.						
LIST OF REFERENCES CITED BY ABPLICANT			FILING DATE		GROUP					
		/ Mak .								
	•				August 26, 2003 2681					
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS			ILING DATE PPROPRIATE		
/EB/	AA	6,342,810 B1	01/29/2002	Andrew S. WRIGHT, et al.				· 		
/EB/	AB	6,335,767 B1	01/01/2002	Edwin Ray TWITCHELL, et al.			· — , <u>— —</u> — — ,			
	AC									
	AD		<u> </u>							
	AE			•				·		
	AF			·						
	AG							·		
	AH									
	Al						<del></del>			
	AJ	· · · · · · · · · · · · · · · · · · ·								
	AK									
	AL							······································		
	AM				<del></del>		<del></del> ;			
}	AN		<del></del>		<b>-</b>					
				DEIGN DATENT DOCUMENTS						
		<u> </u>	FU	REIGN PATENT DOCUMENTS		<u> </u>				
		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		LATION NO		
/EB/	AO	0 998 027 A1	05/03/2000	EUROPE						
	AP									
	AQ									
·	ÁR									
	AS									
	AT									
	AU				•					
	AV									
		OTHER R	EFERENCES	(Including Author, Title, Date, Pertine)	nt Pages, é	itc.)				
	AW									
	AX									
	AY									
	AZ			,	Add	itional Refe	erences	sheet(s) attached		
Examiner	/Emmanuel Bayard/ (04/03/2007)					Date Considered				
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										